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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/087,201	03/01/2002	Toshiaki Hayashi	021525-000200US	8595
7590	07/27/2004		EXAMINER	NGUYEN, HUNG T
Townsend and Townsend and Crew LLP 8th Floor Two Embarcadero Center San Francisco, CA 94111			ART UNIT	PAPER NUMBER
			2636	11
			DATE MAILED: 07/27/2004	

Please find below and/or attached an Office communication concerning this application or proceeding.

Examiner-Initiated Interview Summary	Application No.	Applicant(s)
	10/087,201 Examiner Hung T. Nguyen	HAYASHI ET AL. Art Unit 2636

All Participants:

Status of Application: Final Rejection

(1) Hung T. Nguyen.

(3) Tyrome Y. Brown.

(2) Chun-pok Leung.

(4) _____.

Date of Interview: 21 July 2004

Time: 1 P. M

Type of Interview:

Telephonic

Video Conference

Personal (Copy given to: Applicant Applicant's representative)

Exhibit Shown or Demonstrated: Yes No

If Yes, provide a brief description:

Part I.

Rejection(s) discussed:

Annular structure of graphical display.

Claims discussed:

Independent claims and 6 & 17.

Prior art documents discussed:

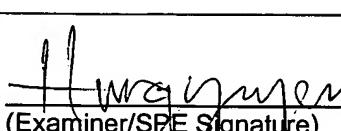
Part II.

SUBSTANCE OF INTERVIEW DESCRIBING THE GENERAL NATURE OF WHAT WAS DISCUSSED:

Applicant will submit a Request for Continued Examination with new limitations in figures 2 & 4 of the invention.

Part III.

- It is not necessary for applicant to provide a separate record of the substance of the interview, since the interview directly resulted in the allowance of the application. The examiner will provide a written summary of the substance of the interview in the Notice of Allowability.
- It is not necessary for applicant to provide a separate record of the substance of the interview, since the interview did not result in resolution of all issues. A brief summary by the examiner appears in Part II above.


(Examiner/SPE Signature)

(Applicant/Applicant's Representative Signature – if appropriate)